SILICON (Si) POWER MOSFET ▲ CED30P10



CED30P10

-100V ▲ 63mΩ ▲ -27A ▲ Si MOSFET

SILICON Si MOSFET ▲ THT type P-channel enhancement mode UL94V-0 rated flame retardant epoxy TO251 (E-PAK) package Super high dense cell density for extremely low R_{DS(ON)} High power and current handling capability







MAXIMUM RATINGS

| Parameter (T _c = 25°C, unless otherwise noted) | | Characteristics |
|---|-----------------------------------|-----------------|
| Drain-Source Voltage | V _{DS} | -100V |
| Gate-Source Voltage | V _{GS} | ±20V |
| Continuous Drain Current | I _D | -27A |
| Pulsed Drain Current Note 1 | I _{DM} | -108A |
| Maximum Power Dissipation at T _c = 25°C | PD | 100W |
| Power Dissipation Derating above 25°C | ΔP _D | 0.66W/°C |
| Operating and Storage Temperature Range | T _J , T _{STG} | -55°C to +175°C |

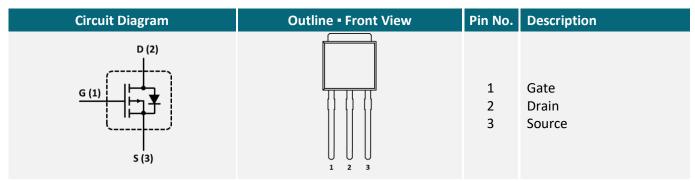
THERMAL CHARACTERISTICS

| Parameter | Symbol | Limit |
|--|--------------------|---------|
| Thermal Resistance, Junction-to-Case | R _{TH_JC} | 1.5°C/W |
| Thermal Resistance, Junction-to-Ambient Note 2 | R _{TH_JA} | 50°C/W |

APPLICATIONS

| DC/DC | DC | Load | Power | USB |
|-----------|------------|----------|-------|---------|
| Converter | Fan | Switches | Banks | Storage |
| | \bigcirc | | 4 | Ŷ |

PIN DESCRIPTION



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ELECTRICAL CHARACTERISTICS A T_c = 25°C, unless otherwise noted

| ltem | Condition | Symbol | Min. | Тур. | Max. | Unit |
|---|--|---------------------|------|------|------|------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | $V_{GS} = 0V, I_{D} = -250 \mu A$ | BV _{DSS} | -100 | | | V |
| Zero Gate Voltage Drain Current | V_{DS} = -100V, V_{GS} = 0V | I _{DSS} | | | -1 | μA |
| Gate Body Leakage Current, Forward | V_{GS} = 20V, V_{DS} = 0V | I _{GSSF} | | | 100 | nA |
| Gate Body Leakage Current, Reverse | V_{GS} = -20V, V_{DS} = 0V | I _{GSSR} | | | -100 | nA |
| On Characteristics Note 4 | | | | | | |
| Gate Threshold Voltage | $V_{GS} = V_{DS}$, $I_{D} = -250 \mu A$ | V _{GS(th)} | -1 | | -3 | V |
| Static Drain-Source On-Resistance | $V_{GS} = -10V, I_{D} = -15A$ | R _{DS(ON)} | | 63 | 76 | mΩ |
| Static Drain-Source On-Resistance | V_{GS} = -4.5V, I_{D} = -8A | R _{DS(ON)} | | 72 | 92 | mΩ |
| Dynamic Characteristics Note 4 | | | | | | |
| Input Capacitance | $V_{DS} = -25V, V_{GS} = 0V, f = 1MHz$ | CISS | | 2550 | | рF |
| Output Capacitance | V_{DS} = -25V, V_{GS} = 0V, f = 1MHz | Coss | | 345 | | рF |
| Reverse Transfer Capacitance | V_{DS} = -25V, V_{GS} = 0V, f = 1MHz | C _{RSS} | | 70 | | pF |
| Switching Characteristics Note 4 | | | | | | |
| Turn-On Delay Time | $\label{eq:V_DD} \begin{array}{l} V_{DD} = -50V, \ V_{GS} = -10V, \ I_{D} = -18A, \\ R_{G(ext)} = 3.3\Omega \end{array}$ | t _{D(ON)} | | 16 | | ns |
| Turn-On Rise Time | $\label{eq:V_DD} \begin{array}{l} V_{DD} = \texttt{-50V}, \ V_{GS} = \texttt{-10V}, \ I_{D} = \texttt{-18A}, \\ R_{G(ext)} = 3.3\Omega \end{array}$ | t _R | | 7 | | ns |
| Turn-Off Delay Time | $\label{eq:V_DD} \begin{array}{l} \text{V}_{\text{DD}} = \text{-50V}, \ \text{V}_{\text{GS}} = \text{-10V}, \ \text{I}_{\text{D}} = \text{-18A}, \\ \text{R}_{\text{G}(\text{ext})} = 3.3\Omega \end{array}$ | $t_{D(OFF)}$ | | 120 | | ns |
| Turn-Off Fall Time | V_{DD} = -50V, V_{GS} = -10V, I_D = -18A, $R_{G(ext)}$ = 3.3 Ω | t _F | | 25 | | ns |
| Total Gate Charge | V_{DS} = -80V, V_{GS} = -10V, I_D = -18A | Q_{G} | | 78 | | nC |
| Gate Source Charge | V_{DS} = -80V, V_{GS} = -10V, I_D = -18A | Q _{GS} | | 8 | | nC |
| Gate Drain Charge | $V_{DS} = -80V, V_{GS} = -10V, I_D = -18A$ | \mathbf{Q}_{GD} | | 20 | | nC |
| Drain-Source Diode Characteristics and | nd Maximum Ratings | | | | | |
| Drain-Source Diode Forward Current ^{Note 2} | | Is | | | -27 | А |
| Drain-Source Diode Forward Voltage ^{Note 3} | V _{GS} = 0V, I _S = -16A | V_{SD} | | | -1.2 | V |

Notes

1: Repetitive Rating: Pulse width limited by maximum junction temperature

2: Surface Mounted on FR4 Board, $t \le 10$ sec.

3: Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2%.

4: Guaranteed by design, not subject to production testing.



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REFERENCE DATA ▲ TYPICAL DEVICE PERFORMANCE

Fig. 1 • Output Characteristics Fig. 2 • Transfer Characteristics 25 40 ₃₈=10,8,7,6,5V 25°C 20 32 -ID, Drain Current (A) ID, Drain Current (A) 15 24 -V_{GS}=4V 10 16 T_J=1<u>25℃</u> -55 C 5 8 /_{GS}=3V 0 0 0.0 2 3 4 5 1 0 2 6 1 3 4 5 -VDS, Drain-to-Source Voltage (V) -VGS, Gate-to-Source Voltage (V) Fig. 4 • On-Resistance Variation with Temperature Fig. 3 • Capacitance 3000 2.2 I_D=-15A RDS(ON), Normalized RDS(ON), On-Resistance(Ohms) Ciss V_{GS}=-10V 1.9 2500 C, Capacitance (pF) 2000 1.6 1500 1.3 1.0 1000 0.7 500 Coss C_{rss} 0.4 0 5 10 15 20 -100 -50 0 50 100 150 200 0 25 -VDS, Drain-to-Source Voltage (V) TJ, Junction Temperature(°C) Fig. 6 - Body Diode Forward Voltage Variation Fig. 5 • Gate Threshold Variation with Temperature with Source Current 1.3 V_{DS}=V_{GS} V_{GS}=0V Gate-Source Threshold Voltage Is, Source-drain current (A) I_D=-250μΑ 1.2 10² VTH, Normalized 1.1 1.0 0.9 10¹ 0.8 0.7 10⁰ 0.6 -25 0 25 50 75 -50 100 125 150 0.4 0.6 0.8 1.0 1.2 1.4 TJ, Junction Temperature(°C) -Vsp, Body Diode Forward Voltage (V)



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REFERENCE DATA ▲ TYPICAL DEVICE PERFORMANCE

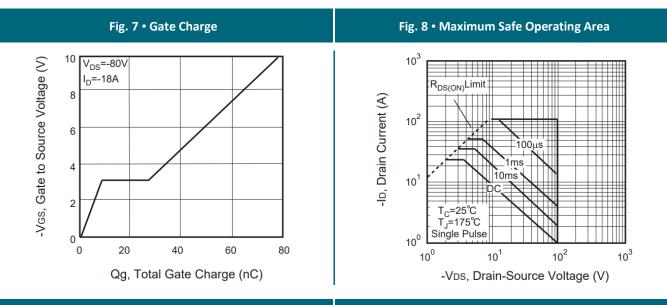
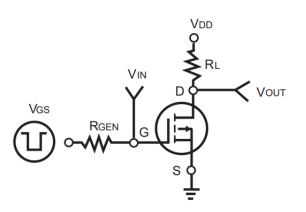


Fig. 9 - Switching Test Circuit



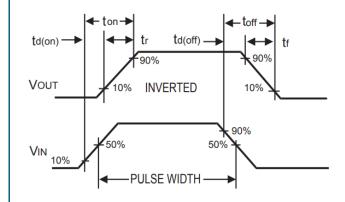
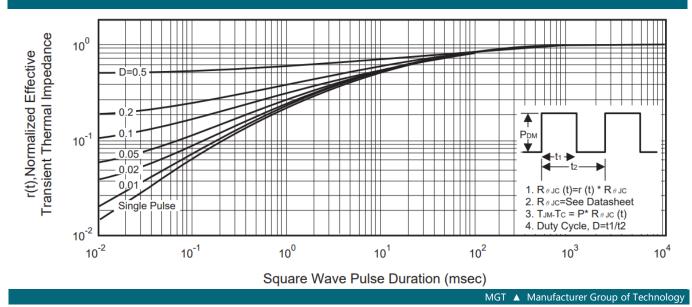


Fig. 10 - Switching Waveforms

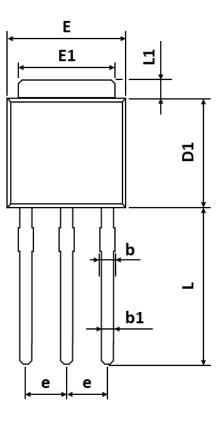
Fig. 11 • Normalized Thermal Transient Impedance Curve

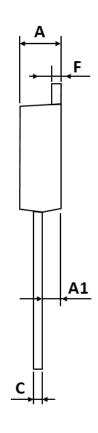


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PACKAGE OUTLINE





| Sym | Millimeters (Min.) | Millimeters (Typ.) | Millimeters (Max.) |
|-----|-----------------------|-----------------------|-----------------------|
| А | 2.180 | - | 2.400 |
| A1 | 0.860 | - | 1.500 |
| b | 0.700 | - | 0.960 |
| b1 | 0.700 | - | 0.860 |
| С | 0.400 | - | 0.610 |
| D1 | 5.400 | - | 6.630 |
| E | 6.050 | - | 7.010 |
| E1 | 4.950 | - | 5.460 |
| е | 1.980 | - | 2.590 |
| F | 0.400 | - | 0.890 |
| L | 8.500 | - | 9.650 |
| L1 | 0.500 | - | 1.800 |

ORDERING INFORMATION

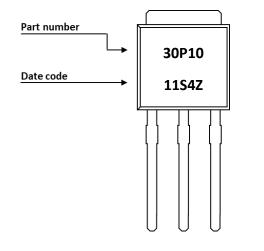
| Part Number | Package | Packing | Tube Qty. | Inner Box Qty. | Outer Box Qty. |
|-------------|---------------|---------|-----------|----------------|----------------|
| CED30P10 | TO251 (E-PAK) | Tube | 80pcs | 4,000pcs | 16,000pcs |

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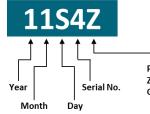
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PART MARKING



DATE CODE

Example: 11S4Z



| Product Type Z: Pb-free G: Green Product

| | Coding list for "Day" | | | | | | | | |
|----------------|-----------------------|----------|----------|----------|----------|----------|----------|----------|----------|
| 1 01 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | A |
| | 02 | 03 | 04 | 05 | 06 | 07 | 08 | 09 | 10 |
| B | C | D | E | F | G | H | | J | K |
| 11 | 12 | 13 | 14 | 15 | 16 | 17 | 18 | 19 | 20 |
| L | M | N | O | P | Q | R | S | T | U |
| 21 | 22 | 23 | 24 | 25 | 26 | 27 | 28 | 29 | 30 |
| V 31 | | | | | | | | | |

Coding list for "Month"

| 1 Jan | 2 Feb | | 5 May | |
|-----------------|-----------------|--|-----------------|-----------------|
| 7 Jul | 8 Aug | | B Nov | C Dec |

Coding list for "Year"

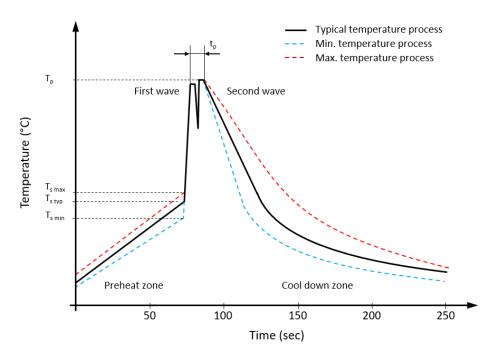


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RECOMMENDED WAVE SOLDERING PROFILE ▲ THT PACKAGE



Classification wave soldering profile ▲ Refer to EN 61760-1: 2006

| Profile Features | | Value 🛦 Sn-Pb Assembly | Value 🔺 Pb-free Assembly |
|--|--------------------|--|--|
| Preheat temperature min. | $T_{s min}$ | 100 °C | 100 °C |
| Preheat temperature typical | T _{s typ} | 120 °C | 120 °C |
| Preheat temperature max. | $T_{s max}$ | 130 °C | 130 °C |
| Preheat time t_s from $T_{s min}$ to $T_{s max}$ | ts | 70 seconds | 70 seconds |
| Peak temperature | Tp | 235 °C to 260 °C | 245 °C to 260 °C |
| Time of actual peak temperature | t _p | Max. 10 seconds Max. 5 second each wave | Max. 10 seconds Max. 5 second each wave |
| Ramp-down date min. | | ~ 2 °C/second | ~ 2 °C/second |
| Ramp-down rate typical | | ~ 3.5 °C/second | ~ 3.5 °C/second |
| Ramp-down rate max. | | ~ 5 °C/second | ~ 5 °C/second |
| Time 25°C to 25°C | | 4 minutes | 4 minutes |



REVISION TABLE

| Revision | Date | Status | Notes |
|----------|------------|-----------------|---------------------|
| 001 | 30/09/2022 | Initial release | Initial publication |
| | | | |
| | | | |
| | | | |
| | | | |
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